Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/775,164	LEE ET AL.	
Examiner	Art Unit	
Jin-Cheng Wang	2672	

SEARCHED					
Class	Subclass	Date	Examiner		
345	660	9/7/2005	JCW		

INTERFERENCE SEARCHED					
Subclass	Date	Examiner			
660	9/7/2005	JCM			
<u> </u>					
	Subclass	Subclass Date			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
		DATE	EXMR
EAST		9/7/2005	JCM